JETIR.ORG

ISSN: 2349-5162 | ESTD Year: 2014 | Monthly Issue



JOURNAL OF EMERGING TECHNOLOGIES AND INNOVATIVE RESEARCH (JETIR)

An International Scholarly Open Access, Peer-reviewed, Refereed Journal

Ref No: JETIR / Vol 8 / Issue 7 / 287

Confirmation Letter

To,

ASHISH UGLE

Published in : Volume 8 | Issue 7 | 2021-07-12



Subject: Publication of paper at International Journal of Emerging Technologies and Innovative Research.

Dear Author,

With Greetings we are informing you that your paper has been successfully published in the International Journal of Emerging Technologies and Innovative Research (ISSN: 2349-5162). Following are the details regarding the published paper.

: An International Scholarly Open Access Journal, Peer-Reviewed, Refereed About JETIR

> Journal Impact Factor Calculate by Google Scholar and Semantic Scholar | AI-Powered Research Tool, Multidisciplinary, Monthly, Multilanguage Journal Indexing in All Major Database & Metadata, Citation Generator, Impact Factor:

7.95, ISSN: 2349-5162

UGC Approval: UGC and ISSN Approved - UGC Approved Journal No: 63975 | Link:

https://www.ugc.ac.in/journallist/subjectwisejurnallist.aspx?tid=MjM0OTUxNjI

=&&did=U2VhcmNoIGJ5IElTU04=

Registration ID: JETIR 312389 Paper ID : JETIR2107287

Title of Paper : Wavelet Entropy Energy Based Distance Protection of Transmission Line

Impact Factor : 7.95 (Calculate by Google Scholar)

DOI

Published in : Volume 8 | Issue 7 | 2021-07-12

Publication Date: 2021-07-12 Page No : c155-c160

Published URL: http://www.jetir.org/view?paper=JETIR2107287 : ASHISH UGLE, Mr.HARSHAL TAKPIRE Authors

Thank you very much for publishing your article in JETIR. We would appreciate if you continue your support and keep sharing your knowledge by writing for our journal JETIR.

















International Journal of Emerging Technologies and Innovative Research (ISSN: 2349-5162)

www.jetir.org | editor@jetir.org | Impact Factor: 7.95 (Calculate by Google Scholar)

An International Scholarly Open Access Journal, Peer-Reviewed, Refereed Journal